

BF1205C

Dual N-channel dual gate MOS-FET

Rev. 01 — 18 May 2004

Product data sheet

1. Product profile

1.1 General description

The BF1205C is a combination of two dual gate MOS-FET amplifiers with shared source and gate 2 leads and an integrated switch. The integrated switch is operated by the gate 1 bias of amplifier b.

The source and substrate are interconnected. Internal bias circuits enable DC stabilization and a very good cross-modulation performance during AGC. Integrated diodes between the gates and source protect against excessive input voltage surges. The transistor has a SOT363 micro-miniature plastic package.

CAUTION



This device is sensitive to electrostatic discharge (ESD). Therefore care should be taken during transport and handling.

1.2 Features

- Two low noise gain controlled amplifiers in a single package; one with a fully integrated bias and one with a partly integrated bias
- Internal switch to save external components
- Superior cross-modulation performance during AGC
- High forward transfer admittance
- High forward transfer admittance to input capacitance ratio.

1.3 Applications

- Gain controlled low noise amplifiers for VHF and UHF applications with 5 V supply voltage
 - ◆ digital and analog television tuners
 - ◆ professional communication equipment.

PHILIPS

1.4 Quick reference data

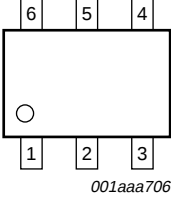
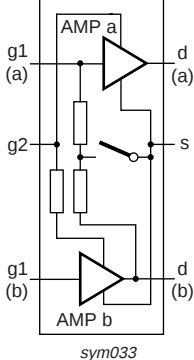
Table 1: Quick reference data
Per MOS-FET unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V_{DS}	drain-source voltage		-	-	6	V
I_D	drain current (DC)		-	-	30	mA
P_{tot}	total power dissipation	$T_s \leq 107\text{ }^{\circ}\text{C}$	[1]	-	180	mW
$ y_{fs} $	forward transfer admittance	$f = 1\text{ MHz}$				
		amplifier a; $I_D = 19\text{ mA}$	26	31	41	mS
		amplifier b; $I_D = 13\text{ mA}$	28	33	43	mS
C_{ig1-ss}	input capacitance at gate 1	$f = 1\text{ MHz}$				
		amplifier a	-	2.2	2.7	pF
		amplifier b	-	2.0	2.5	pF
C_{rss}	reverse transfer capacitance	$f = 1\text{ MHz}$	-	20	-	fF
NF	noise figure	amplifier a; $f = 400\text{ MHz}$	-	1.3	1.9	dB
		amplifier b; $f = 800\text{ MHz}$	-	1.4	2.1	dB
X_{mod}	cross-modulation	input level for $k = 1\%$ at 40 dB AGC				
		amplifier a	100	105	-	dB μ V
		amplifier b	100	103	-	dB μ V
T_j	junction temperature		-	-	150	$^{\circ}\text{C}$

[1] T_s is the temperature at the soldering point of the source lead.

2. Pinning information

Table 2: Discrete pinning

Pin	Description	Simplified outline	Symbol
1	gate 1 (a)		
2	gate 2		
3	gate 1 (b)		
4	drain (b)		
5	source		
6	drain (a)		

3. Ordering information

Table 3: Ordering information

Type number	Package		
	Name	Description	Version
BF1205C	-	plastic surface mounted package; 6 leads	SOT363

4. Marking

Table 4: Marking

Type number	Marking code ^[1]
BF1205C	M6*

- [1] * = p or -: made in Hong Kong.
 * = t: made in Malaysia.
 * = W: made in China.

5. Limiting values

Table 5: Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
Per MOS-FET					
V_{DS}	drain-source voltage		-	6	V
I_D	drain current (DC)		-	30	mA
I_{G1}	gate 1 current		-	±10	mA
I_{G2}	gate 2 current		-	±10	mA
P_{tot}	total power dissipation	$T_s \leq 107\text{ °C}$ ^[1]	-	180	mW
T_{stg}	storage temperature		-65	+150	°C
T_j	junction temperature		-	150	°C

- [1] T_s is the temperature at the soldering point of the source lead.

6. Thermal characteristics

Table 6: Thermal characteristics

Symbol	Parameter	Conditions	Typ	Unit
$R_{th(j-s)}$	thermal resistance from junction to soldering point		240	K/W

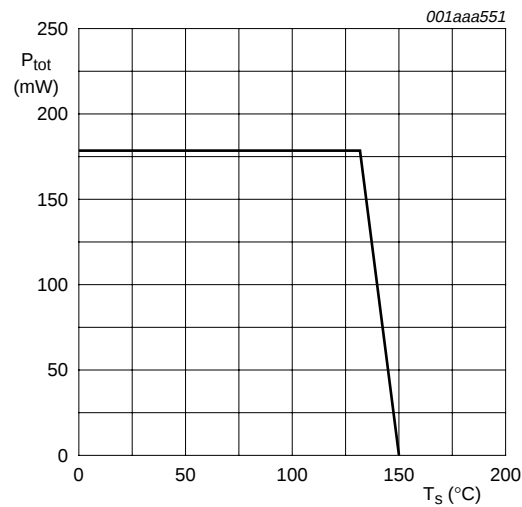


Fig 1. Power derating curve.

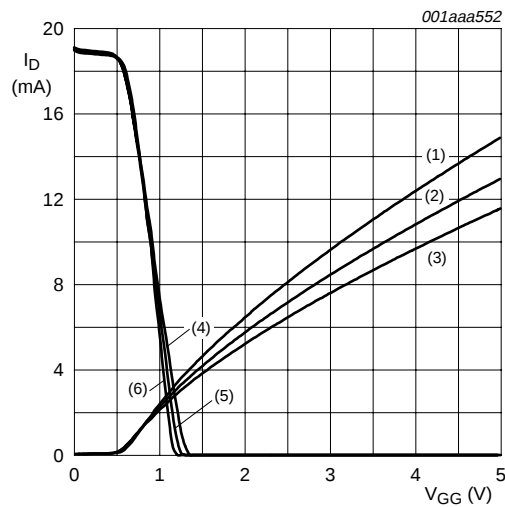
7. Static characteristics

Table 7: Static characteristics

 $T_j = 25^\circ\text{C}$.

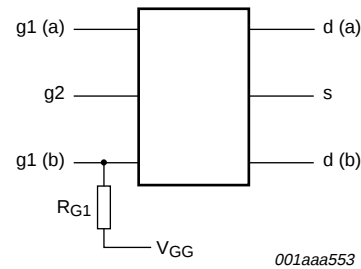
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Per MOS-FET; unless otherwise specified						
$V_{(BR)DSS}$	drain-source breakdown voltage	$V_{G1-S} = V_{G2-S} = 0\text{ V}$; $I_D = 10\text{ }\mu\text{A}$				
		amplifier a	6	-	-	V
		amplifier b	6	-	-	V
$V_{(BR)G1-SS}$	gate 1-source breakdown voltage	$V_{GS} = V_{DS} = 0\text{ V}$; $I_{G1-S} = 10\text{ mA}$	6	-	10	V
$V_{(BR)G2-SS}$	gate 2-source breakdown voltage	$V_{GS} = V_{DS} = 0\text{ V}$; $I_{G2-S} = 10\text{ mA}$	6	-	10	V
$V_{(F)S-G1}$	forward source-gate 1 voltage	$V_{G2-S} = V_{DS} = 0\text{ V}$; $I_{S-G1} = 10\text{ mA}$	0.5	-	1.5	V
$V_{(F)S-G2}$	forward source-gate 2 voltage	$V_{G1-S} = V_{DS} = 0\text{ V}$; $I_{S-G2} = 10\text{ mA}$	0.5	-	1.5	V
$V_{G1-S(th)}$	gate 1-source threshold voltage	$V_{DS} = 5\text{ V}$; $V_{G2-S} = 4\text{ V}$; $I_D = 100\text{ }\mu\text{A}$	0.3	-	1.0	V
$V_{G2-S(th)}$	gate 2-source threshold voltage	$V_{DS} = 5\text{ V}$; $V_{G1-S} = 5\text{ V}$; $I_D = 100\text{ }\mu\text{A}$	0.4	-	1.0	V
I_{DSX}	drain-source current	$V_{G2-S} = 4\text{ V}$; $V_{DS(b)} = 5\text{ V}$; $R_{G1} = 150\text{ k}\Omega$				
		amplifier a; $V_{DS(a)} = 5\text{ V}$	[1] 14	-	24	mA
		amplifier b	[2] 9	-	17	mA
I_{G1-S}	gate1 cut-off current	$V_{G2-S} = V_{DS(a)} = 0\text{ V}$				
		amplifier a; $V_{G1-S(a)} = 5\text{ V}$; $I_{D(b)} = 0\text{ A}$	-	-	50	nA
		amplifier b; $V_{G1-S(b)} = 5\text{ V}$; $V_{DS(b)} = 0\text{ V}$	-	-	50	nA
I_{G2-S}	gate 2 cut-off current	$V_{G2-S} = 4\text{ V}$; $V_{G1-S(a)} = V_{DS(a)} = V_{DS(b)} = 0\text{ V}$; $V_{G1-S(b)} = 0\text{ V}$;	-	-	20	nA

[1] R_{G1} connects gate 1 (b) to $V_{GG} = 0\text{ V}$ (see Figure 3).[2] R_{G1} connects gate 1 (b) to $V_{GG} = 5\text{ V}$ (see Figure 3).



- (1) $I_{D(b)}$; $R_{G1} = 120 \text{ k}\Omega$.
 (2) $I_{D(b)}$; $R_{G1} = 150 \text{ k}\Omega$.
 (3) $I_{D(b)}$; $R_{G1} = 180 \text{ k}\Omega$.
 (4) $I_{D(a)}$; $R_{G1} = 180 \text{ k}\Omega$.
 (5) $I_{D(a)}$; $R_{G1} = 150 \text{ k}\Omega$.
 (6) $I_{D(a)}$; $R_{G1} = 120 \text{ k}\Omega$.

Fig 2. Drain currents of MOS-FET a and b as function of V_{GG} .



$V_{GG} = 5 \text{ V}$: amplifier a is off; amplifier b is on
 $V_{GG} = 0 \text{ V}$: amplifier a is on; amplifier b is off.

Fig 3. Functional diagram.

8. Dynamic characteristics

8.1 Dynamic characteristics for amplifier a

Table 8: Dynamic characteristics for amplifier a [\[1\]](#)

Common source; $T_{amb} = 25^\circ\text{C}$; $V_{G2-S} = 4 \text{ V}$; $V_{DS} = 5 \text{ V}$; $I_D = 19 \text{ mA}$.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$ y_{fs} $	forward transfer admittance	$T_j = 25^\circ\text{C}$	26	31	41	mS
C_{ig1-ss}	input capacitance at gate 1	$f = 1 \text{ MHz}$	-	2.2	2.7	pF
C_{ig2-ss}	input capacitance at gate 2	$f = 1 \text{ MHz}$	-	3.0	-	pF
C_{oss}	output capacitance	$f = 1 \text{ MHz}$	-	0.9	-	pF
C_{rss}	reverse transfer capacitance	$f = 1 \text{ MHz}$	-	20	-	fF
G_{tr}	power gain	$B_S = B_{S(opt)}$; $B_L = B_{L(opt)}$				
		$f = 200 \text{ MHz}$; $G_S = 2 \text{ mS}$; $G_L = 0.5 \text{ mS}$	31	35	39	dB
		$f = 400 \text{ MHz}$; $G_S = 2 \text{ mS}$; $G_L = 1 \text{ mS}$	26	30	34	dB
		$f = 800 \text{ MHz}$; $G_S = 3.3 \text{ mS}$; $G_L = 1 \text{ mS}$	21	25	29	dB
NF	noise figure	$f = 11 \text{ MHz}$; $G_S = 20 \text{ mS}$; $B_S = 0 \text{ S}$	-	3.0	-	dB
		$f = 400 \text{ MHz}$; $Y_S = Y_{S(opt)}$	-	1.3	1.9	dB
		$f = 800 \text{ MHz}$; $Y_S = Y_{S(opt)}$	-	1.4	2.1	dB

Table 8: Dynamic characteristics for amplifier a [1] ...continued
Common source; $T_{amb} = 25\text{ }^{\circ}\text{C}$; $V_{G2-S} = 4\text{ V}$; $V_{DS} = 5\text{ V}$; $I_D = 19\text{ mA}$.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
X_{mod}	cross-modulation	input level for $k = 1\%$; $f_w = 50\text{ MHz}$; $f_{unw} = 60\text{ MHz}$ [2]				
		at 0 dB AGC	90	-	-	dB μ V
		at 10 dB AGC	-	90	-	dB μ V
		at 20 dB AGC	-	99	-	dB μ V
		at 40 dB AGC	100	105	-	dB μ V

- [1] For the MOS-FET not in use: $V_{G1-S(b)} = 0\text{ V}$; $V_{DS(b)} = 0\text{ V}$.
[2] Measured in Figure 33 test circuit.

8.1.1 Graphs for amplifier a

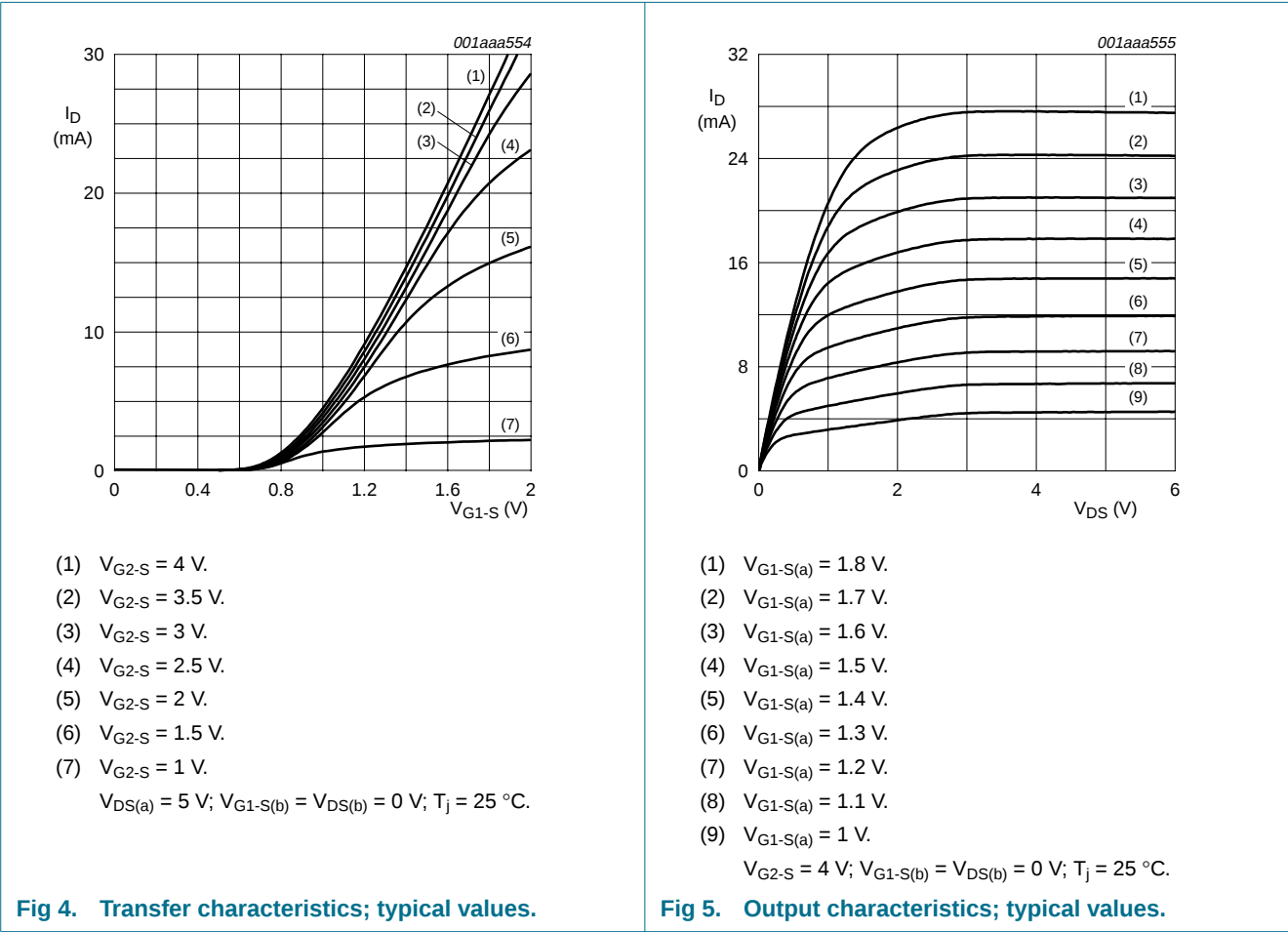
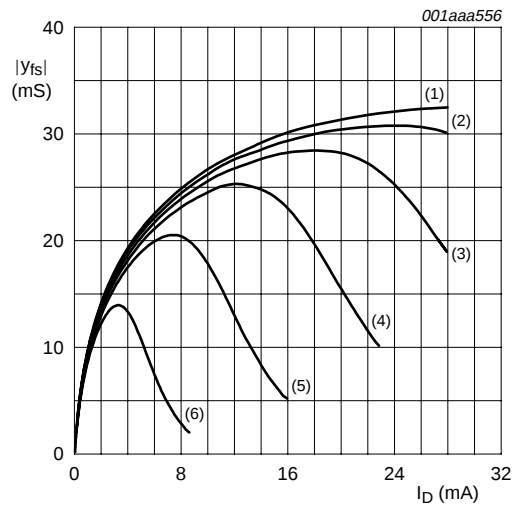


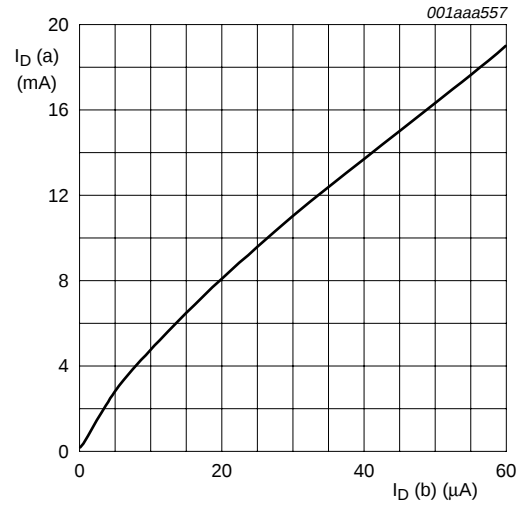
Fig 4. Transfer characteristics; typical values.

Fig 5. Output characteristics; typical values.



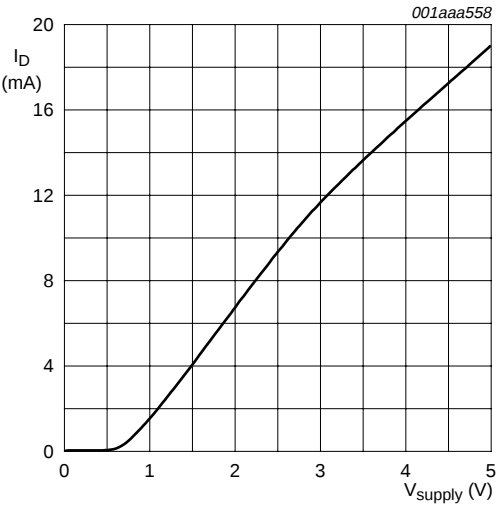
- (1) $V_{G2-S} = 4 \text{ V}$.
 (2) $V_{G2-S} = 3.5 \text{ V}$.
 (3) $V_{G2-S} = 3 \text{ V}$.
 (4) $V_{G2-S} = 2.5 \text{ V}$.
 (5) $V_{G2-S} = 2 \text{ V}$.
 (6) $V_{G2-S} = 1.5 \text{ V}$.
 $V_{DS(a)} = 5 \text{ V}$; $V_{G1-S(b)} = V_{DS(b)} = 0 \text{ V}$; $T_j = 25^\circ\text{C}$.

Fig 6. Forward transfer admittance as a function of drain current; typical values.



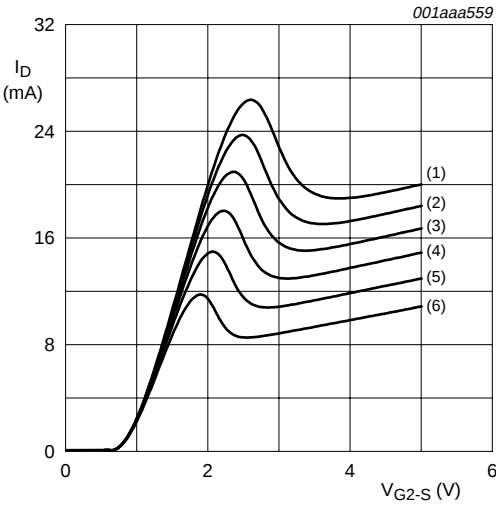
- $V_{DS(a)} = 5 \text{ V}$; $V_{G2-S} = 4 \text{ V}$; $V_{DS(b)} = 5 \text{ V}$;
 $V_{G1-S(b)} = 0 \text{ V}$; $T_j = 25^\circ\text{C}$.

Fig 7. Drain current as a function of internal G1 current (current in pin drain (b) if MOS-FET (b) is switched off); typical values.



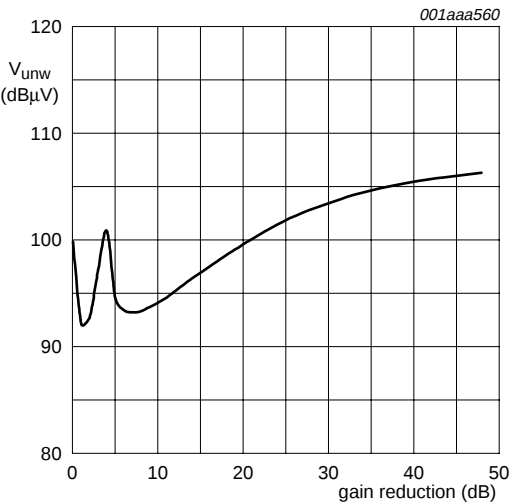
$V_{DS(a)} = V_{DS(b)} = V_{supply}$, $V_{G2-S} = 4\text{ V}$, $T_j = 25\text{ }^{\circ}\text{C}$,
 $R_{G1(b)} = 150\text{ k}\Omega$ (connected to ground); see [Figure 3](#).

Fig 8. Drain current of amplifier a as a function of supply voltage of a and b amplifier; typical values.



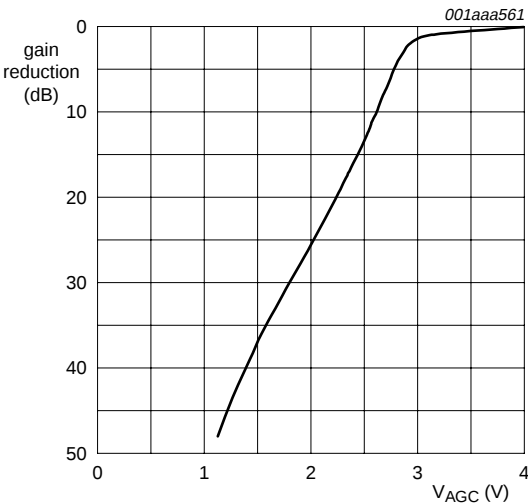
- (1) $V_{DS(b)} = 5\text{ V}$.
 - (2) $V_{DS(b)} = 4.5\text{ V}$.
 - (3) $V_{DS(b)} = 4\text{ V}$.
 - (4) $V_{DS(b)} = 3.5\text{ V}$.
 - (5) $V_{DS(b)} = 3\text{ V}$.
 - (6) $V_{DS(b)} = 2.5\text{ V}$.
- $V_{DS(a)} = 5\text{ V}$; $V_{G1-S(b)} = 0\text{ V}$; gate 1 (a) = open;
 $T_j = 25\text{ }^{\circ}\text{C}$.

Fig 9. Drain current as a function of gate 2 and drain supply voltage; typical values.



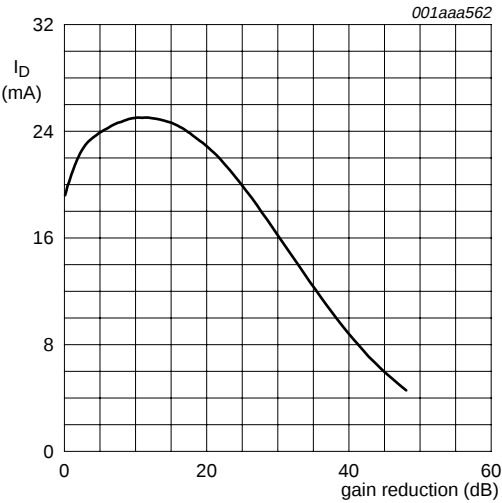
$V_{DS(a)} = V_{DS(b)} = 5\text{ V}$; $V_{G1-S(b)} = 0\text{ V}$; $f_w = 50\text{ MHz}$;
 $f_{unw} = 60\text{ MHz}$; $T_{amb} = 25\text{ }^{\circ}\text{C}$; see [Figure 33](#).

Fig 10. Unwanted voltage for 1% cross-modulation as a function of gain reduction; typical values.



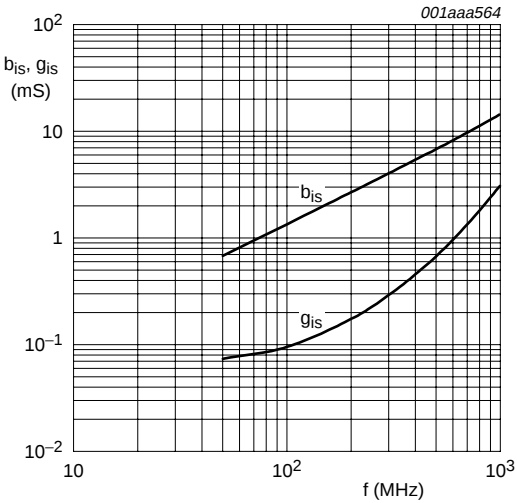
$V_{DS(a)} = V_{DS(b)} = 5\text{ V}$; $V_{G1-S(b)} = 0\text{ V}$; $f = 50\text{ MHz}$; see [Figure 33](#).

Fig 11. Gain reduction as a function of AGC voltage; typical values.



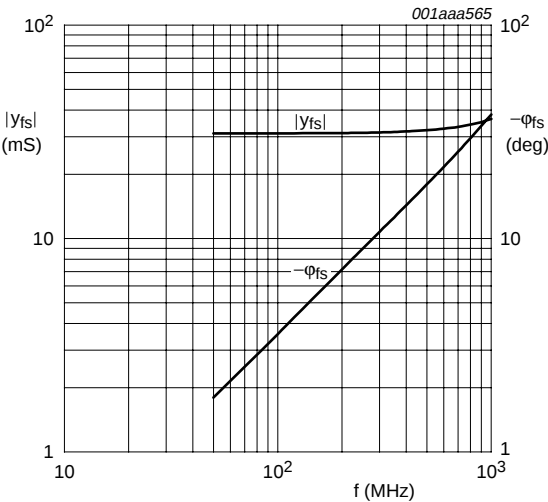
$V_{DS(a)} = V_{DS(b)} = 5\text{ V}$; $V_{G1-S(b)} = 0\text{ V}$; $f = 50\text{ MHz}$;
 $T_{amb} = 25\text{ }^\circ\text{C}$; see [Figure 33](#).

Fig 12. Drain current as a function of gain reduction; typical values.



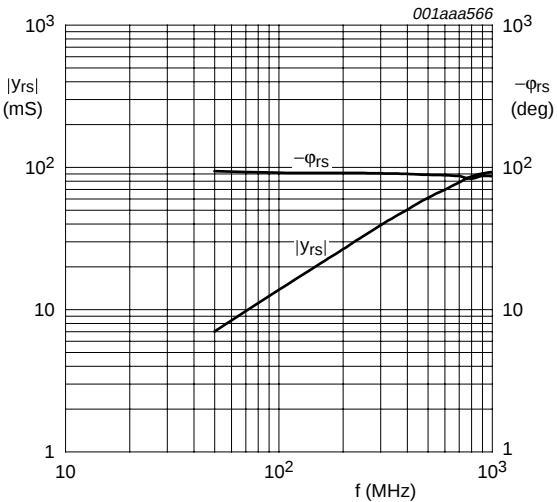
$V_{DS(a)} = 5\text{ V}$; $V_{G2-S(a)} = 4\text{ V}$; $V_{DS(b)} = V_{G1-S(b)} = 0\text{ V}$;
 $I_{D(a)} = 19\text{ mA}$.

Fig 13. Input admittance as a function of frequency; typical values.



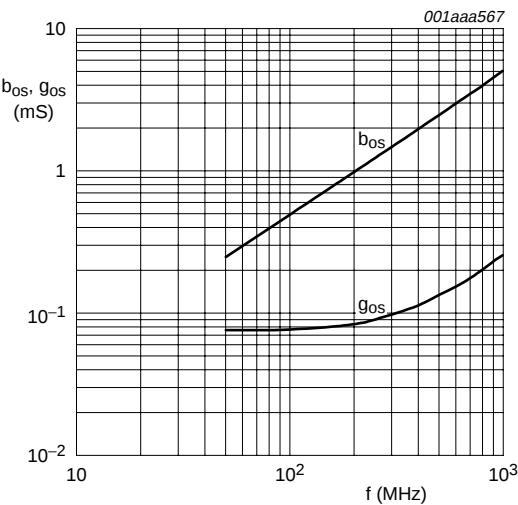
$V_{DS(a)} = 5\text{ V}$; $V_{G2-S(a)} = 4\text{ V}$; $V_{DS(b)} = V_{G1-S(b)} = 0\text{ V}$;
 $I_{D(a)} = 19\text{ mA}$.

Fig 14. Forward transfer admittance and phase as a function of frequency; typical values.



$V_{DS(a)} = 5\text{ V}$; $V_{G2-S(a)} = 4\text{ V}$; $V_{DS(b)} = V_{G1-S(b)} = 0\text{ V}$;
 $I_{D(a)} = 19\text{ mA}$.

Fig 15. Reverse transfer admittance and phase as a function of frequency; typical values.



$V_{DS(a)} = 5\text{ V}$; $V_{G2-S(a)} = 4\text{ V}$; $V_{DS(b)} = V_{G1-S(b)} = 0\text{ V}$; $I_{D(a)} = 19\text{ mA}$.

Fig 16. Output admittance as a function of frequency; typical values.

8.1.2 Scattering parameters for amplifier a

Table 9: Scattering parameters for amplifier a
 $V_{DS(a)} = 5\text{ V}$; $V_{G2-S} = 4\text{ V}$; $I_{D(a)} = 19\text{ mA}$; $V_{DS(b)} = 0\text{ V}$; $V_{G-1S(b)} = 0\text{ V}$; $T_{amb} = 25\text{ }^{\circ}\text{C}$.

f (MHz)	S ₁₁		S ₂₁		S ₁₂		S ₂₂	
	Magnitude ratio	Angle (deg)	Magnitude ratio	Angle (deg)	Magnitude ratio	Angle (deg)	Magnitude ratio	Angle (deg)
50	0.992	-3.91	3.07	175.56	0.0007	83.61	0.992	-1.47
100	0.990	-7.76	3.06	171.18	0.0017	83.19	0.992	-2.93
200	0.982	-15.42	3.04	162.42	0.0026	78.19	0.990	-5.84
300	0.971	-22.99	3.01	153.79	0.0037	73.75	0.988	-8.71
400	0.956	-30.52	2.96	145.22	0.0047	69.82	0.985	-11.59
500	0.938	-37.83	2.90	136.78	0.0055	66.12	0.982	-14.48
600	0.917	-45.14	2.83	128.46	0.0061	62.11	0.979	-17.31
700	0.893	-52.31	2.76	120.20	0.0065	58.86	0.975	-20.14
800	0.867	-59.47	2.69	111.98	0.0068	58.28	0.972	-22.98
900	0.838	-66.23	2.60	103.90	0.0067	50.64	0.968	-25.85
1000	0.807	-73.10	2.52	95.875	0.0065	47.28	0.966	-28.74

8.1.3 Noise data for amplifier a

Table 10: Noise data for amplifier a
 $V_{DS(a)} = 5\text{ V}$; $V_{G2-S} = 4\text{ V}$; $I_{D(a)} = 19\text{ mA}$; $V_{DS(b)} = 0\text{ V}$; $V_{G-1S(b)} = 0\text{ V}$; $T_{amb} = 25\text{ }^{\circ}\text{C}$.

f (MHz)	F _{min} (dB)	Γ _{opt}		r _n (Ω)
		ratio	(deg)	
400	1.3	0.718	16.06	0.683
800	1.4	0.677	37.59	0.681

8.2 Dynamic characteristics for amplifier b

Table 11: Dynamic characteristics for amplifier b

Common source; $T_{amb} = 25\text{ }^{\circ}\text{C}$; $V_{G2-S} = 4\text{ V}$; $V_{DS} = 5\text{ V}$; $I_D = 13\text{ mA}$.

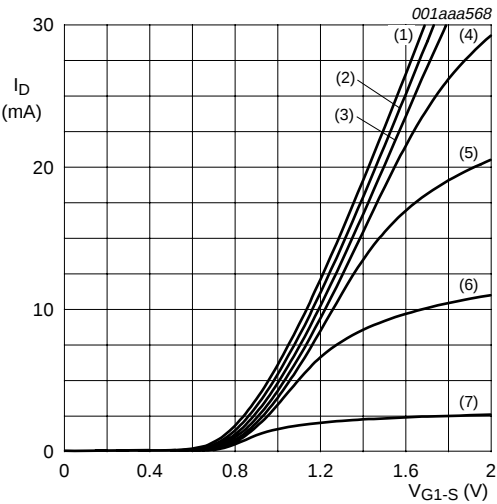
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$ y_{fs} $	forward transfer admittance	$T_j = 25\text{ }^{\circ}\text{C}$	28	33	43	mS
C_{ig1-ss}	input capacitance at gate 1	$f = 1\text{ MHz}$	-	2.0	2.5	pF
C_{ig2-ss}	input capacitance at gate 2	$f = 1\text{ MHz}$	-	3.4	-	pF
C_{oss}	output capacitance	$f = 1\text{ MHz}$	-	0.85	-	pF
C_{rss}	reverse transfer capacitance	$f = 1\text{ MHz}$	-	20	-	fF
G_{tr}	power gain	$B_S = B_{S(opt)}$; $B_L = B_{L(opt)}$	[1]			
		$f = 200\text{ MHz}$; $G_S = 2\text{ mS}$; $G_L = 0.5\text{ mS}$	31	35	39	dB
		$f = 400\text{ MHz}$; $G_S = 2\text{ mS}$; $G_L = 1\text{ mS}$	28	32	36	dB
		$f = 800\text{ MHz}$; $G_S = 3.3\text{ mS}$; $G_L = 1\text{ mS}$	24	28	32	dB
NF	noise figure	$f = 11\text{ MHz}$; $G_S = 20\text{ mS}$; $B_S = 0\text{ S}$	-	5	-	dB
		$f = 400\text{ MHz}$; $Y_S = Y_{S(opt)}$	-	1.3	1.9	dB
		$f = 800\text{ MHz}$; $Y_S = Y_{S(opt)}$	-	1.4	2.1	dB
X_{mod}	cross-modulation	input level for $k = 1\%$; $f_w = 50\text{ MHz}$; $f_{unw} = 60\text{ MHz}$	[2]			
		at 0 dB AGC	90	-	-	dB μ V
		at 10 dB AGC	-	88	-	dB μ V
		at 20 dB AGC	-	94	-	dB μ V
		at 40 dB AGC	100	103	-	dB μ V

[1] For the MOS-FET not in use: $V_{G1-S(a)} = 0\text{ V}$; $V_{DS(a)} = 0\text{ V}$.

[2] Measured in [Figure 34](#) test circuit.



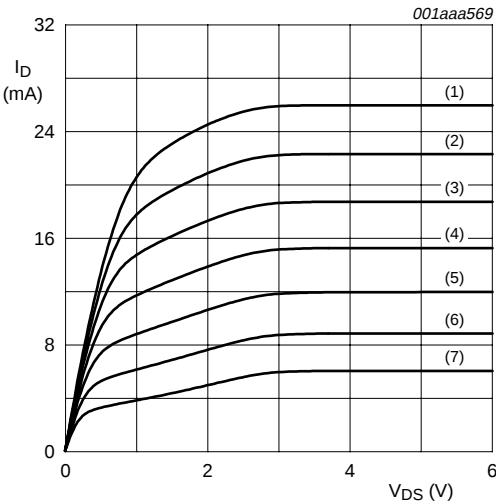
8.2.1 Graphs for amplifier b



- (1) $V_{G2-S} = 4 \text{ V.}$
- (2) $V_{G2-S} = 3.5 \text{ V.}$
- (3) $V_{G2-S} = 3 \text{ V.}$
- (4) $V_{G2-S} = 2.5 \text{ V.}$
- (5) $V_{G2-S} = 2 \text{ V.}$
- (6) $V_{G2-S} = 1.5 \text{ V.}$
- (7) $V_{G2-S} = 1 \text{ V.}$

$V_{DS(b)} = 5 \text{ V; } V_{DS(a)} = V_{G1-S(a)} = 0 \text{ V; } T_j = 25 \text{ }^{\circ}\text{C.}$

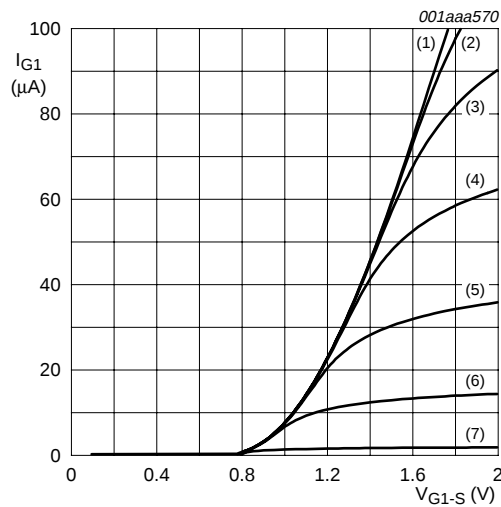
Fig 17. Transfer characteristics; typical values.



- (1) $V_{G1-S(b)} = 1.6 \text{ V.}$
- (2) $V_{G1-S(b)} = 1.5 \text{ V.}$
- (3) $V_{G1-S(b)} = 1.4 \text{ V.}$
- (4) $V_{G1-S(b)} = 1.3 \text{ V.}$
- (5) $V_{G1-S(b)} = 1.2 \text{ V.}$
- (6) $V_{G1-S(b)} = 1.1 \text{ V.}$
- (7) $V_{G1-S(b)} = 1 \text{ V.}$

$V_{G2-S} = 4 \text{ V; } V_{DS(a)} = V_{G1-S(a)} = 0 \text{ V; } T_j = 25 \text{ }^{\circ}\text{C.}$

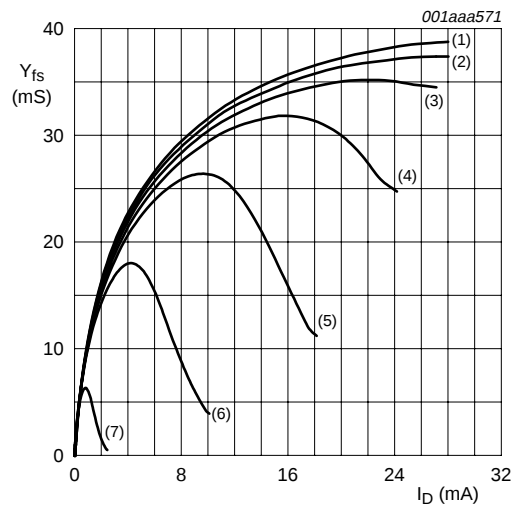
Fig 18. Output characteristics; typical values.



- (1) $V_{G2-S} = 4 \text{ V}$.
- (2) $V_{G2-S} = 3.5 \text{ V}$.
- (3) $V_{G2-S} = 3 \text{ V}$.
- (4) $V_{G2-S} = 2.5 \text{ V}$.
- (5) $V_{G2-S} = 2 \text{ V}$.
- (6) $V_{G2-S} = 1.5 \text{ V}$.
- (7) $V_{G2-S} = 1 \text{ V}$.

$V_{DS(b)} = 5 \text{ V}$; $V_{DS(a)} = V_{G1-S(a)} = 0 \text{ V}$; $T_j = 25^\circ \text{C}$.

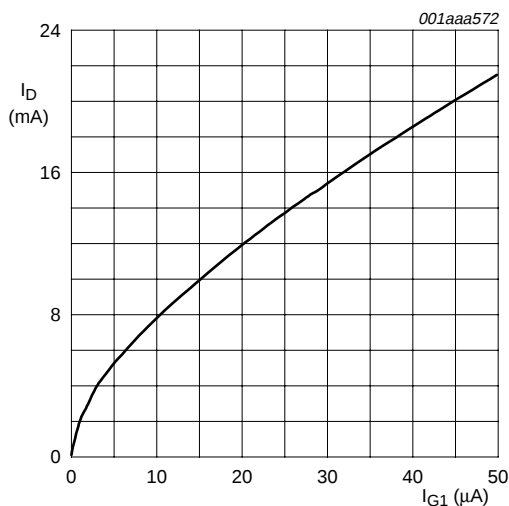
Fig 19. Gate 1 current as a function of gate 1 voltage; typical values.



- (1) $V_{G2-S} = 4 \text{ V}$.
- (2) $V_{G2-S} = 3.5 \text{ V}$.
- (3) $V_{G2-S} = 3 \text{ V}$.
- (4) $V_{G2-S} = 2.5 \text{ V}$.
- (5) $V_{G2-S} = 2 \text{ V}$.
- (6) $V_{G2-S} = 1.5 \text{ V}$.
- (7) $V_{G2-S} = 1 \text{ V}$.

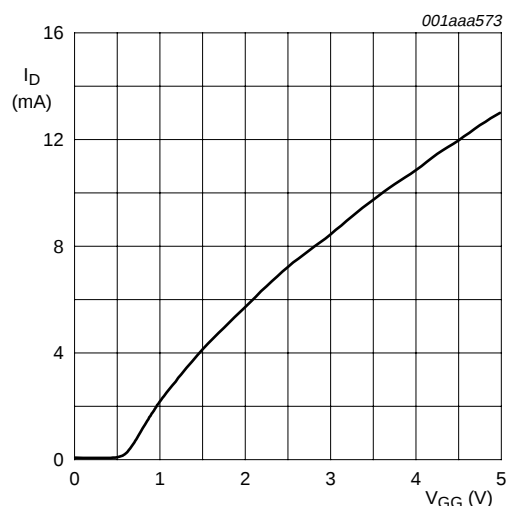
$V_{DS(b)} = 5 \text{ V}$; $V_{DS(a)} = V_{G1-S(a)} = 0 \text{ V}$; $T_j = 25^\circ \text{C}$.

Fig 20. Forward transfer admittance as a function of drain current; typical values.



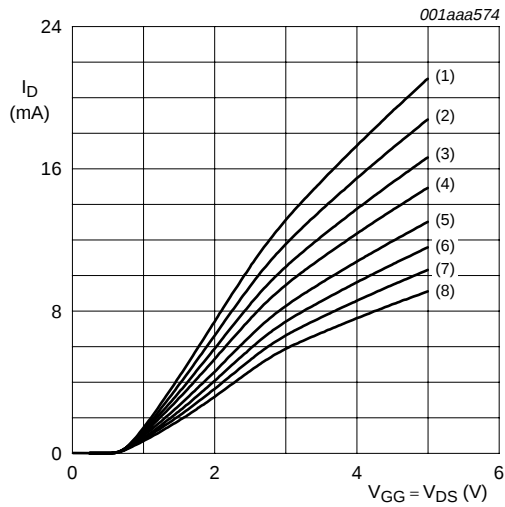
$V_{DS(b)} = 5 \text{ V}$; $V_{G2-S} = 4 \text{ V}$; $V_{DS(a)} = V_{G1-S(a)} = 0 \text{ V}$;
 $T_j = 25^\circ \text{C}$.

Fig 21. Drain current as a function of gate 1 current; typical values.



$V_{DS(b)} = 5 \text{ V}$; $V_{G2-S} = 4 \text{ V}$; $V_{DS(a)} = V_{G1-S(a)} = 0 \text{ V}$;
 $T_j = 25^\circ \text{C}$; $R_{G1(b)} = 150 \text{ k}\Omega$ (connected to V_{GG}); see [Figure 3](#).

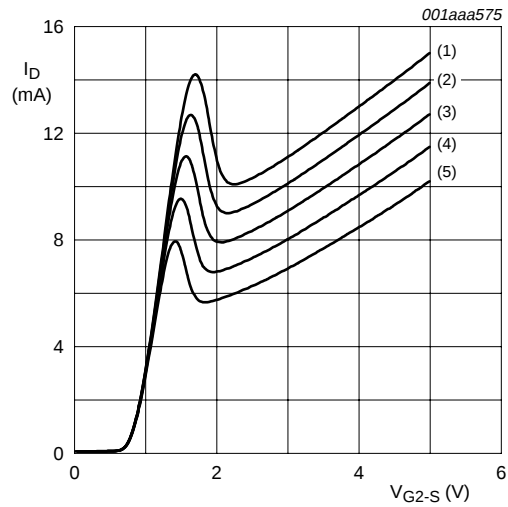
Fig 22. Drain current as a function of gate 1 supply voltage (V_{GG}); typical values.



- (1) $R_{G1(b)} = 68 \text{ k}\Omega$.
- (2) $R_{G1(b)} = 82 \text{ k}\Omega$.
- (3) $R_{G1(b)} = 100 \text{ k}\Omega$.
- (4) $R_{G1(b)} = 120 \text{ k}\Omega$.
- (5) $R_{G1(b)} = 150 \text{ k}\Omega$.
- (6) $R_{G1(b)} = 180 \text{ k}\Omega$.
- (7) $R_{G1(b)} = 220 \text{ k}\Omega$.
- (8) $R_{G1(b)} = 270 \text{ k}\Omega$.

$V_{G2-S} = 4 \text{ V}$; $V_{DS(a)} = V_{G1-S(a)} = 0 \text{ V}$; $T_j = 25 \text{ }^\circ\text{C}$;
 $R_{G1(b)}$ is connected to V_{GG} ; see [Figure 3](#).

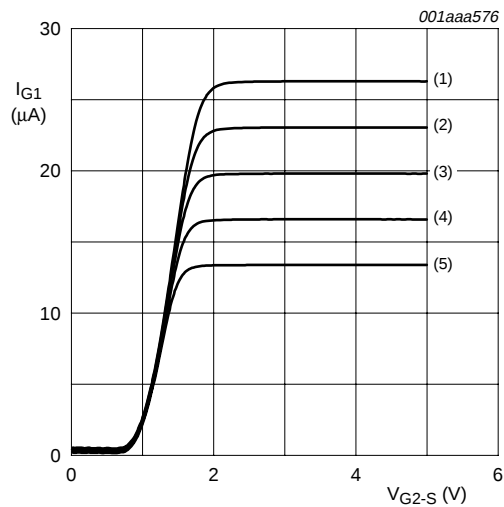
Fig 23. Drain current as a function of gate 1 (V_{GG}), drain supply voltage and value of R_{G1} ; typical values.



- (1) $V_{GG} = 5.0 \text{ V}$.
- (2) $V_{GG} = 4.5 \text{ V}$.
- (3) $V_{GG} = 4.0 \text{ V}$.
- (4) $V_{GG} = 3.5 \text{ V}$.
- (5) $V_{GG} = 3.0 \text{ V}$.

$V_{DS(b)} = 5 \text{ V}$; $V_{DS(a)} = V_{G1-S(a)} = 0 \text{ V}$; $T_j = 25 \text{ }^\circ\text{C}$;
 $R_{G1(b)} = 150 \text{ k}\Omega$ (connected to V_{GG}); see [Figure 3](#).

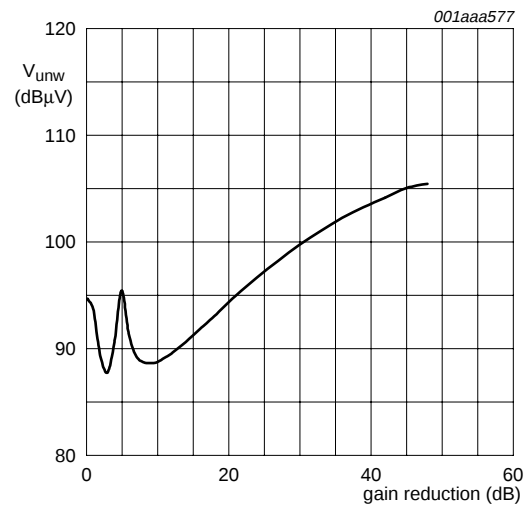
Fig 24. Drain current as a function of gate 2 voltage; typical values.



- (1) $V_{GG} = 5.0 \text{ V}$.
- (2) $V_{GG} = 4.5 \text{ V}$.
- (3) $V_{GG} = 4.0 \text{ V}$.
- (4) $V_{GG} = 3.5 \text{ V}$.
- (5) $V_{GG} = 3.0 \text{ V}$.

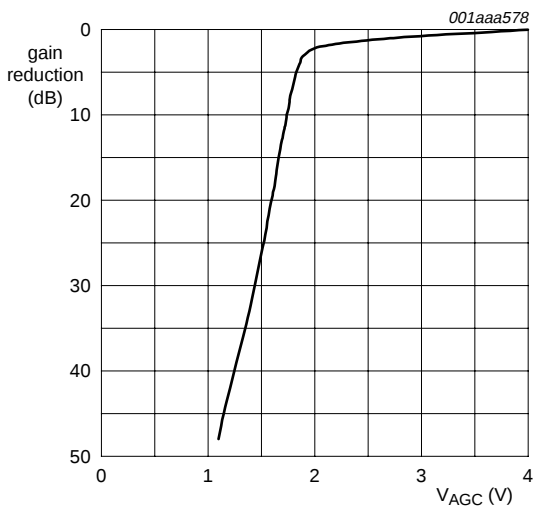
$V_{DS(b)} = 5 \text{ V}$; $V_{DS(a)} = V_{G1-S(a)} = 0 \text{ V}$; $T_j = 25 \text{ }^\circ\text{C}$;
 $R_{G1(b)} = 150 \text{ k}\Omega$ (connected to V_{GG}); see [Figure 3](#).

Fig 25. Gate 1 current as a function of gate 2 voltage; typical values.



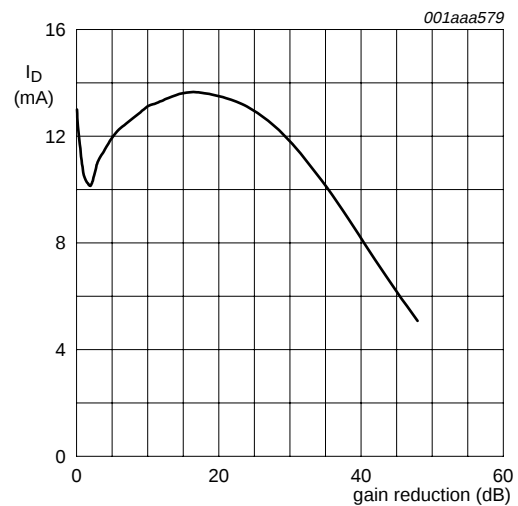
$V_{DS(b)} = 5 \text{ V}$; $V_{GG} = 5 \text{ V}$; $V_{DS(a)} = V_{G1-S(a)} = 0 \text{ V}$;
 $R_{G1(b)} = 150 \text{ k}\Omega$ (connected to V_{GG}); $f_w = 50 \text{ MHz}$;
 $f_{unw} = 60 \text{ MHz}$; $T_{amb} = 25 \text{ }^\circ\text{C}$; see [Figure 34](#).

Fig 26. Unwanted voltage for 1% cross-modulation as a function of gain reduction; typical values.



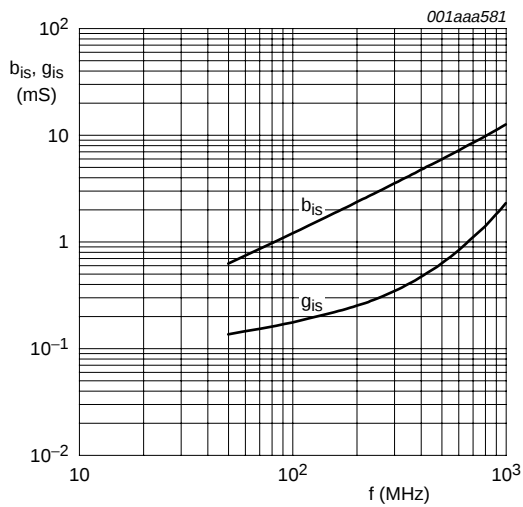
$V_{DS(b)} = 5 \text{ V}$; $V_{GG} = 5 \text{ V}$; $V_{DS(a)} = V_{G1-S(a)} = 0 \text{ V}$;
 $R_{G1(b)} = 150 \text{ k}\Omega$ (connected to V_{GG}); $f = 50 \text{ MHz}$;
 $T_{amb} = 25 \text{ }^\circ\text{C}$; see [Figure 34](#).

Fig 27. Typical gain reduction as a function of AGC voltage.



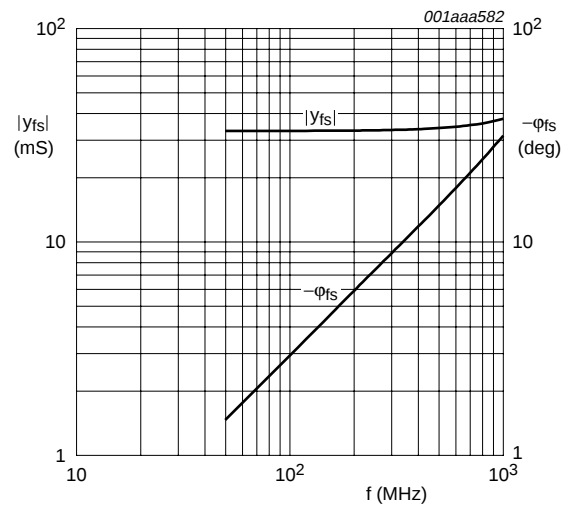
$V_{DS(b)} = 5 \text{ V}$; $V_{GG} = 5 \text{ V}$; $V_{DS(a)} = V_{G1-S(a)} = 0 \text{ V}$;
 $R_{G1(b)} = 150 \text{ k}\Omega$ (connected to V_{GG}); $f = 50 \text{ MHz}$;
 $T_{amb} = 25 \text{ }^\circ\text{C}$; see [Figure 34](#).

Fig 28. Drain current as a function of gain reduction; typical values.



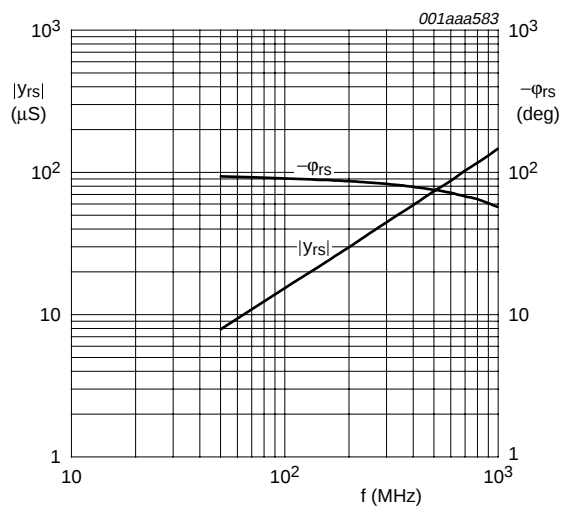
$V_{DS(b)} = 5$ V; $V_{G2-S} = 4$ V; $V_{DS(a)} = V_{G1-S(a)} = 0$ V;
 $I_{D(b)} = 13$ mA.

Fig 29. Input admittance as a function of frequency; typical values.



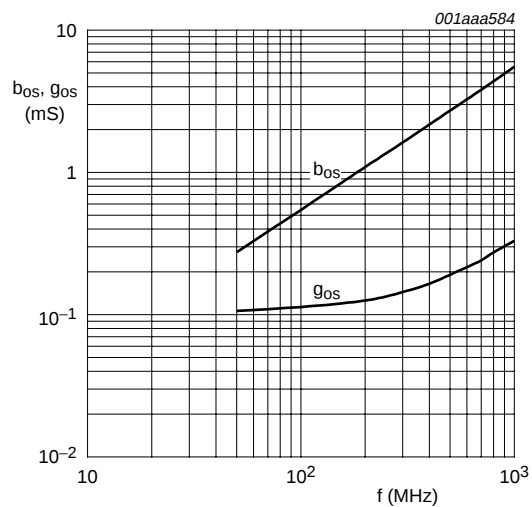
$V_{DS(b)} = 5$ V; $V_{G2-S} = 4$ V; $V_{DS(a)} = V_{G1-S(a)} = 0$ V;
 $I_{D(b)} = 13$ mA.

Fig 30. Forward transfer admittance and phase as a function of frequency; typical values.



$V_{DS(b)} = 5$ V; $V_{G2-S} = 4$ V; $V_{DS(a)} = V_{G1-S(a)} = 0$ V;
 $I_{D(b)} = 13$ mA.

Fig 31. Reverse transfer admittance and phase as a function of frequency; typical values.



$V_{DS(b)} = 5$ V; $V_{G2-S} = 4$ V; $V_{DS(a)} = V_{G1-S(a)} = 0$ V;
 $I_{D(b)} = 13$ mA.

Fig 32. Output admittance as a function of frequency; typical values.

8.2.2 Scattering parameters for amplifier b

Table 12: Scattering parameters for amplifier b

$V_{DS(b)} = 5\text{ V}$; $V_{G2-S} = 4\text{ V}$; $I_{D(b)} = 13\text{ mA}$; $V_{DS(a)} = 0\text{ V}$; $V_{G1-S(a)} = 0\text{ V}$; $T_{amb} = 25\text{ °C}$.

f (MHz)	S ₁₁		S ₂₁		S ₁₂		S ₂₂	
	Magnitude ratio	Angle (deg)	Magnitude ratio	Angle (deg)	Magnitude ratio	Angle (deg)	Magnitude ratio	Angle (deg)
50	0.986	-3.66	3.26	175.93	0.0008	84.23	0.988	-1.65
100	0.982	-7.01	3.24	172.04	0.0015	84.91	0.988	-3.27
200	0.975	-13.71	3.22	164.24	0.0029	83.96	0.986	-6.50
300	0.966	-20.36	3.19	156.53	0.0042	82.86	0.984	-9.69
400	0.955	-27.04	3.15	148.86	0.0055	81.88	0.982	-12.88
500	0.943	-33.62	3.10	141.24	0.0066	80.92	0.978	-16.07
600	0.927	-40.16	3.05	133.70	0.0076	80.15	0.975	-19.21
700	0.909	-46.70	2.99	126.13	0.0086	79.68	0.972	-22.35
800	0.891	-52.07	2.92	118.64	0.0094	78.28	0.968	-25.52
900	0.868	-59.48	2.84	111.09	0.0100	78.28	0.965	-28.65
1000	0.846	-65.86	2.77	103.58	0.0107	78.15	0.961	-31.85

8.2.3 Noise data for amplifier b

Table 13: Noise data for amplifier b

$V_{DS(b)} = 5\text{ V}$; $V_{G2-S} = 4\text{ V}$; $I_{D(b)} = 13\text{ mA}$; $V_{DS(a)} = 0\text{ V}$; $V_{G1-S(a)} = 0\text{ V}$; $T_{amb} = 25\text{ °C}$.

f (MHz)	F _{min} (dB)	Γ _{opt}		r _n (Ω)
		ratio	(deg)	
400	1.3	0.695	13.11	0.694
800	1.4	0.674	32.77	0.674



9. Test information

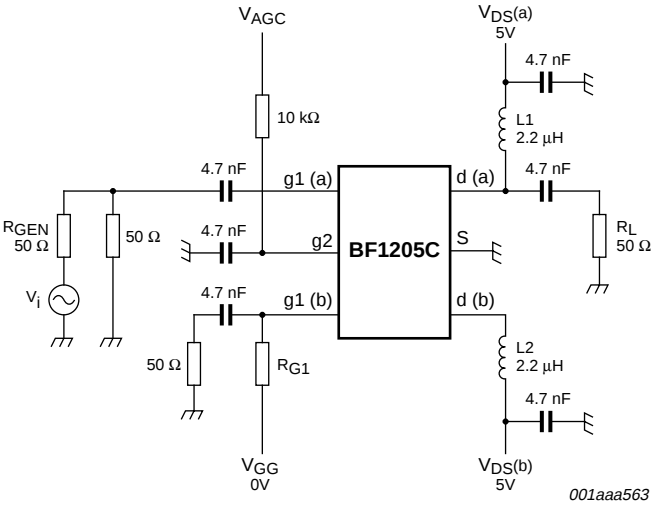


Fig 33. Cross-modulation test set-up for amplifier a.

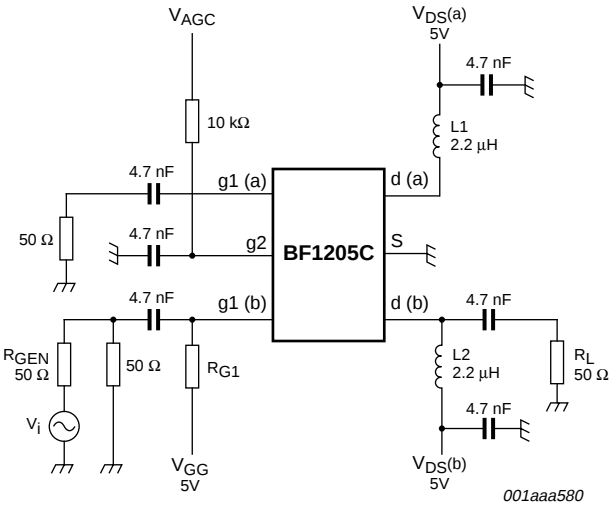


Fig 34. Cross-modulation test set-up for amplifier b.

10. Package outline

Plastic surface mounted package; 6 leads

SOT363

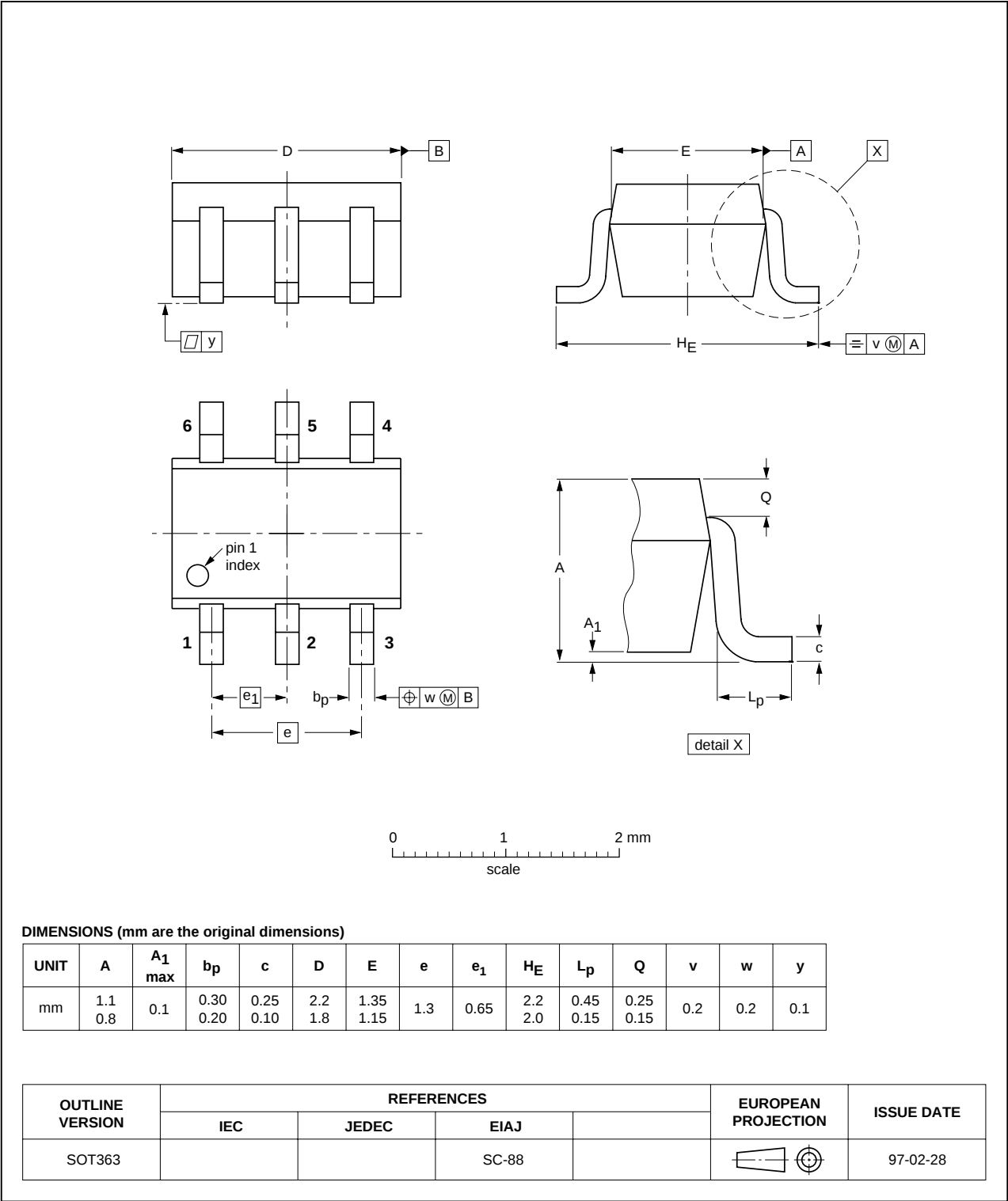


Fig 35. Package outline.

11. Revision history

Table 14: Revision history

Document ID	Release date	Data sheet status	Change notice	Order number	Supersedes
BF1205C_1	20040518	Product data	-	9397 750 13005	-

12. Data sheet status

Level	Data sheet status ^[1]	Product status ^{[2] [3]}	Definition
I	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
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[2] The product status of the device(s) described in this data sheet may have changed since this data sheet was published. The latest information is available on the Internet at URL <http://www.semiconductors.philips.com>.

[3] For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.

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